Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/069,017	MATHIEU ET AL.
Examiner	Art Unit
Dzung D. Tran	2633

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(1	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR		
EAST	SEARCH SEARCH	05/12/0	79		
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